

November 2011

### **FDMC7696**

# N-Channel PowerTrench $^{\! \rm I\!R}$ MOSFET 30 V, 12 A, 11.5 m $\Omega$

#### **Features**

- Max  $r_{DS(on)}$  = 11.5 m $\Omega$  at  $V_{GS}$  = 10 V,  $I_D$  = 12 A
- Max  $r_{DS(on)}$  = 14.5 m $\Omega$  at  $V_{GS}$  = 4.5 V,  $I_D$  = 10 A
- High performance technology for extremely low r<sub>DS(on)</sub>
- Termination is Lead-free and RoHS Compliant

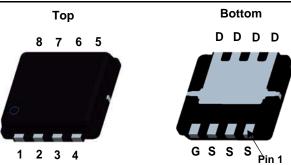
#### **General Description**

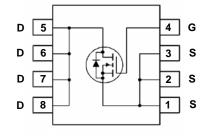
This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced Power Trench® process that has been especially tailored to minimize the on-state resistance. This device is well suited for Power Management and load switching applications common in Notebook Computers and Portable Battery Packs.

#### **Applications**

- DC/DC Buck Converters
- Notebook battery power management
- Load Switch in Notebook







MLP 3.3x3.3

#### MOSFET Maximum Ratings T<sub>A</sub> = 25 ℃ unless otherwise noted

Symbol	Parameter			Ratings	Units	
$V_{DS}$	Drain to Source Voltage			30	V	
$V_{GS}$	Gate to Source Voltage		(Note 4)	±20	V	
	Drain Current -Continuous (Package limited)	T <sub>C</sub> = 25℃		20		
	-Continuous (Silicon limited)	T <sub>C</sub> = 25℃		38	Α	
'D	-Continuous	T <sub>A</sub> = 25℃	(Note 1a)	12	_ ^	
	-Pulsed			50		
E <sub>AS</sub>	Single Pulse Avalanche Energy		(Note 3)	21	mJ	
В	Power Dissipation	T <sub>C</sub> = 25℃		25	W	
$P_D$	Power Dissipation	T <sub>A</sub> = 25℃	(Note 1a)	2.4	VV	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Ra	ange		-55 to +150	C	

#### **Thermal Characteristics**

$R_{\theta JC}$	Thermal Resistance, Junction to Case	5.0	℃/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	53	C/VV

#### **Package Marking and Ordering Information**

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMC7696	FDMC7696	MLP 3.3x3.3	13 "	12 mm	3000 units

## **Electrical Characteristics** $T_J = 25 \text{ } \text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units		
Off Chara	Off Characteristics							
$BV_{DSS}$	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	30			V		
$\frac{\Delta BV_{DS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	$I_D$ = 250 μA, referenced to 25 °C		14		mV/℃		
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 24 V, V <sub>GS</sub> = 0 V			1	μΑ		
I <sub>GSS</sub>	Gate to Source Leakage Current, Forward	V <sub>GS</sub> = 20 V, V <sub>DS</sub> = 0 V			100	nA		

#### On Characteristics

V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	1.2	2.0	3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D$ = 250 $\mu$ A, referenced to 25 $^{\circ}$ C		-6		mV/℃
	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 12 A		8.5	11.5		
rno( )	Static Drain to Source On Resistance	$V_{GS} = 4.5 \text{ V}, I_D = 10 \text{ A}$		11.5	14.5	mΩ
r <sub>DS(on)</sub> Static Drain to Source On Resistance	$V_{GS} = 10 \text{ V, } I_{D} = 12 \text{ A,}$ $T_{J} = 125  \text{C}$		11.6	15.7	11122	
9 <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> = 5 V, I <sub>D</sub> = 12 A		45		S

#### **Dynamic Characteristics**

C <sub>iss</sub>	Input Capacitance	V 45 V V 0 V		1075	1430	pF
C <sub>oss</sub>	Output Capacitance	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1 MHz		380	505	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	1 - 1 101112		40	55	pF
$R_g$	Gate Resistance		0.2	1.0	2.0	Ω

#### **Switching Characteristics**

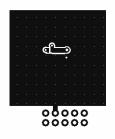
t <sub>d(on)</sub>	Turn-On Delay Time		9	18	ns
t <sub>r</sub>	Rise Time	V <sub>DD</sub> = 15 V, I <sub>D</sub> = 12 A,	2	10	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	$V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$	19	33	ns
t <sub>f</sub>	Fall Time		2	10	ns
$Q_g$	Total Gate Charge	V <sub>GS</sub> = 0 V to 10 V	16	22	nC
$Q_{g}$	Total Gate Charge	$V_{GS} = 0 \text{ V to 5 V} V_{DD} = 15 \text{ V},$	8	11	nC
$Q_{gs}$	Gate to Source Charge	I <sub>D</sub> = 12 A	3.2		nC
$Q_{gd}$	Gate to Drain "Miller" Charge		1.8		nC

#### **Drain-Source Diode Characteristics**

V Source to Drain Diode Forus	Source to Drain Diode Forward Voltage	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 1.9 A (Note 2)	0.75	1.2	V
V SD	V <sub>SD</sub> Source to Drain Diode Forward Voltage	$V_{GS} = 0 V, I_{S} = 12 A$ (Note 2)	0.84	1.2	v
t <sub>rr</sub>	Reverse Recovery Time	-I <sub>E</sub> = 12 A, di/dt = 100 A/μs	25	40	ns
Q <sub>rr</sub>	Reverse Recovery Charge	- 1 <sub>F</sub> = 12 A, αι/αι = 100 A/μS	9	18	nC

Notes:

1. R<sub>BJA</sub> is determined with the device mounted on a 1 in<sup>2</sup> pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R<sub>BJC</sub> is guaranteed by design while R<sub>BCA</sub> is determined by the user's board design.



a. 53 °C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper.



b. 125 °C/W when mounted on a minimum pad of 2 oz copper.

<sup>2.</sup> Pulse Test: Pulse Width < 300  $\mu\text{s},$  Duty cycle < 2.0%.

<sup>3.</sup>  $E_{AS}$  of 21 mJ is based on starting  $T_J$  = 25 °C, L = 0.3 mH,  $I_{AS}$  = 12 A,  $V_{DD}$  = 27 V,  $V_{GS}$  = 10 V.

<sup>4.</sup> As an N-ch device, the negative Vgs rating is for low duty cycle pulse ocurrence only. No continuous rating is implied.

#### Typical Characteristics T<sub>J</sub> = 25 ℃ unless otherwise noted

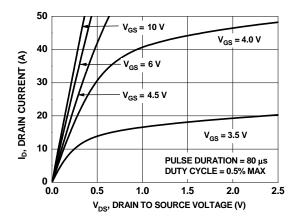


Figure 1. On Region Characteristics

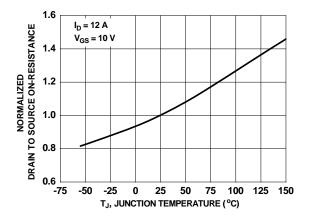


Figure 3. Normalized On Resistance vs Junction Temperature

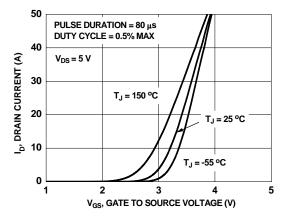


Figure 5. Transfer Characteristics

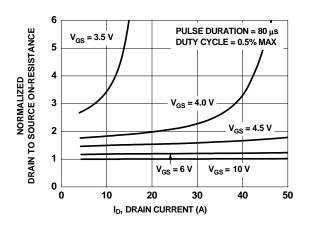


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

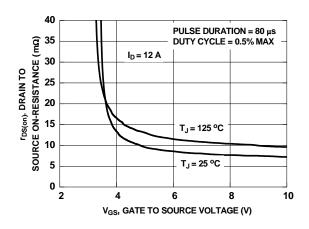


Figure 4. On-Resistance vs Gate to Source Voltage

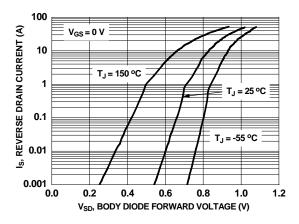


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

#### **Typical Characteristics** $T_J = 25 \text{ } \text{C}$ unless otherwise noted

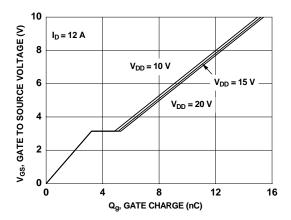


Figure 7. Gate Charge Characteristics

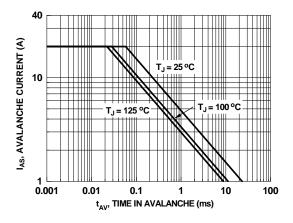


Figure 9. Unclamped Inductive Switching Capability

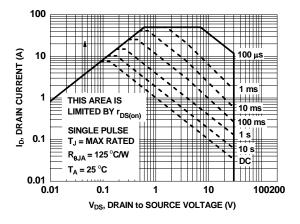


Figure 11. Forward Bias Safe Operating Area

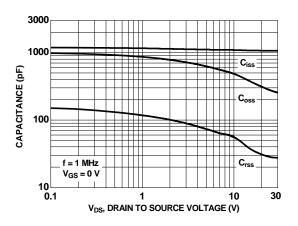


Figure 8. Capacitance vs Drain to Source Voltage

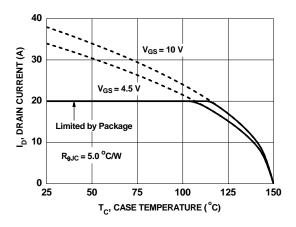


Figure 10. Maximum Continuous Drain Current vs Case Temperature

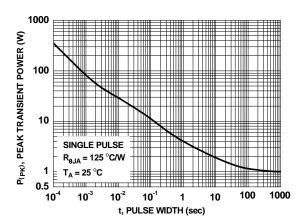


Figure 12. Single Pulse Maximum Power Dissipation



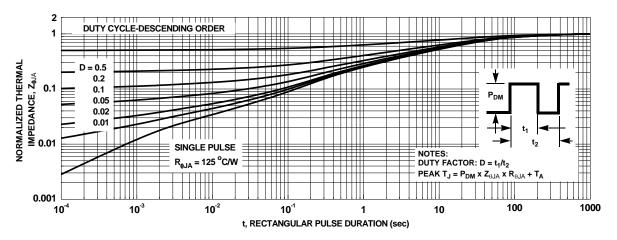
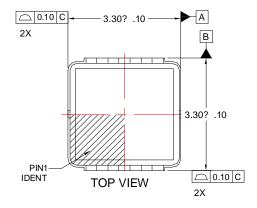
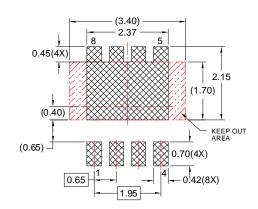
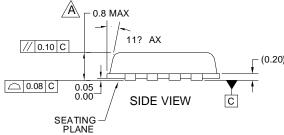


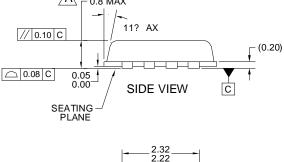
Figure 13. Junction-to-Ambient Transient Thermal Response Curve

#### **Dimensional Outline and Pad Layout**









 $(4X) \begin{array}{c} 0.50 \\ 0.40 \end{array} \begin{array}{c} \hline \\ (1.20) \end{array}$ 

0.50 0.40

8

0.65

# (0.40) 2.10 2.00 A

0.37 0.27 (8X)

⊕ 0.10₩ C A B

0.05(M) C

1.95 **BOTTOM VIEW** 

5

#### RECOMMENDED LAND PATTERN

#### NOTES:

- A EXCEPT AS NOTED, PACKAGE CONFORMS TO JEDEC REGISTRATION MO-240 VARIATION BA..
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 1994.
- D. SEATING PLANE IS DEFINED BY TERMINAL TIPS ONLY
- BODY DIMENSIONS DO NOT INCLUDE MOLD FLASH PROTRUSIONS NOR GATE BURRS.
- F. FLANGE DIMENSIONS INCLUDE INTERTERMINAL FLASH OR PROTRUSION. INTERTERMINAL FLASH OR PROTRUSION SHALL NOT EXCEED 0.25MM PER SIDE.
- G. IT IS RECOMMENDED TO HAVE NO TRACES OR VIA WITHIN THE KEEP OUT AREA.
- H. DRAWING FILENAME
- I. GENERAL RADII FOR ALL CORNERS SHALL BE 0.20MM





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